

NTMS4800N

Power MOSFET 30 V, 8 A, N-Channel, SOIC-8

Features

- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- SOIC-8 Surface Mount Package Saves Board Space
- This is a Pb-Free Device

Applications

- DC-DC Converters
- Printers

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise stated)

| Parameter | | | Symbol | Value | Unit |
|--|--|----------------------------|-------------------|-------------|--------------------|
| Drain-to-Source Voltage | | | V_{DSS} | 30 | V |
| Gate-to-Source Voltage | | | V_{GS} | ± 20 | V |
| Continuous Drain Current $R_{\theta JA}$ (Note 1) | Steady State | $T_A = 25^{\circ}\text{C}$ | I_D | 6.4 | A |
| | | $T_A = 70^{\circ}\text{C}$ | | 5.1 | |
| Power Dissipation $R_{\theta JA}$ (Note 1) | | $T_A = 25^{\circ}\text{C}$ | P_D | 1.29 | W |
| Continuous Drain Current $R_{\theta JA}$ (Note 2) | | $T_A = 25^{\circ}\text{C}$ | I_D | 4.9 | A |
| | | $T_A = 70^{\circ}\text{C}$ | | 3.9 | |
| Power Dissipation $R_{\theta JA}$ (Note 2) | | $T_A = 25^{\circ}\text{C}$ | P_D | 0.75 | W |
| Continuous Drain Current $R_{\theta JA}$, $t < 10$ s (Note 1) | | $T_A = 25^{\circ}\text{C}$ | I_D | 8.0 | A |
| | | $T_A = 70^{\circ}\text{C}$ | | 6.4 | |
| Power Dissipation $R_{\theta JA}$, $t < 10$ s (Note 1) | | $T_A = 25^{\circ}\text{C}$ | P_D | 2.0 | W |
| Pulsed Drain Current | $T_A = 25^{\circ}\text{C}$, $t_p = 10\text{ }\mu\text{s}$ | | I_{DM} | 32 | A |
| Operating Junction and Storage Temperature | | | T_J , T_{stg} | -55 to +150 | $^{\circ}\text{C}$ |
| Source Current (Body Diode) | | | I_S | 2.0 | A |
| Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25^{\circ}\text{C}$, $V_{DD} = 30\text{ V}$, $V_{GS} = 10\text{ V}$, $I_L = 11\text{ A}_{pk}$, $L = 1.0\text{ mH}$, $R_G = 25\text{ }\Omega$) | | | E_{AS} | 60.5 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for $t = 10\text{ s}$) | | | T_L | 260 | $^{\circ}\text{C}$ |

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|--------------------|
| Junction-to-Ambient – Steady State (Note 1) | $R_{\theta JA}$ | 97 | $^\circ\text{C/W}$ |
| Junction-to-Ambient – $t < 10$ s (Note 1) | $R_{\theta JA}$ | 62.5 | |
| Junction-to-Foot (Drain) | $R_{\theta JF}$ | 25 | |
| Junction-to-Ambient – Steady State (Note 2) | $R_{\theta JA}$ | 167 | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 in sq pad, 1 oz Cu
2. Surface-mounted on FR4 board using the minimum recommended pad size

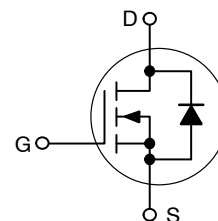


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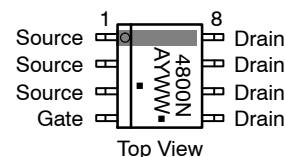
| $V_{(BR)DSS}$ | $R_{DS(ON)}$ MAX | I_D MAX |
|---------------|-----------------------|-----------|
| 30 V | 20 m Ω @ 10 V | 8 A |
| | 27 m Ω @ 4.5 V | |

N-Channel



SO-8
CASE 751
STYLE 12

MARKING DIAGRAM/ PIN ASSIGNMENT



4800N = Device Code
A = Assembly Location
Y = Year
WW = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping† |
|--------------|---------------------|------------------|
| NTMS4800NR2G | SOIC-8 (Pb-Free) | 2500/Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NTMS4800N

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
|---|-------------------|---|---------------------------|-----|-----------|----------------------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-to-Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | 30 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | $V_{(BR)DSS}/T_J$ | | | 26 | | mV/ $^\circ\text{C}$ |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{GS} = 0\text{ V}, V_{DS} = 24\text{ V}$ | $T_J = 25^\circ\text{C}$ | | 1.0 | μA |
| | | | $T_J = 125^\circ\text{C}$ | | 10 | |
| Gate-to-Source Leakage Current | I_{GSS} | $V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$ | | | ± 100 | nA |

ON CHARACTERISTICS (Note 3)

| | | | | | | |
|--|------------------|---|-----|------|-----|----------------------|
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS} = V_{DS}, I_D = 250\text{ }\mu\text{A}$ | 1.5 | | 3.0 | V |
| Negative Threshold Temperature Coefficient | $V_{GS(TH)}/T_J$ | | | 5.0 | | mV/ $^\circ\text{C}$ |
| Drain-to-Source On Resistance | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}, I_D = 7.5\text{ A}$ | | 12.5 | 20 | m Ω |
| | | $V_{GS} = 4.5\text{ V}, I_D = 6.5\text{ A}$ | | 20 | 27 | |
| Forward Transconductance | g_{FS} | $V_{DS} = 1.5\text{ V}, I_D = 7.5\text{ A}$ | | 21 | | S |

CHARGES, CAPACITANCES AND GATE RESISTANCE

| | | | | | | |
|------------------------------|--------------|---|--|------|--|----|
| Input Capacitance | C_{iss} | $V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}, V_{DS} = 15\text{ V}$ | | 940 | | pF |
| Output Capacitance | C_{oss} | | | 225 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 125 | | |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V}, I_D = 7.5\text{ A}$ | | 7.7 | | nC |
| Threshold Gate Charge | $Q_{G(TH)}$ | | | 1.1 | | |
| Gate-to-Source Charge | Q_{GS} | | | 3.3 | | |
| Gate-to-Drain Charge | Q_{GD} | | | 3.2 | | |
| Total Gate Charge | $Q_{G(TOT)}$ | $V_{GS} = 10\text{ V}, V_{DS} = 15\text{ V}, I_D = 7.5\text{ A}$ | | 15.2 | | nC |

SWITCHING CHARACTERISTICS (Note 4)

| | | | | | | |
|---------------------|--------------|---|--|-----|--|----|
| Turn-On Delay Time | $t_{d(on)}$ | $V_{GS} = 10\text{ V}, V_{DS} = 15\text{ V}, I_D = 1.0\text{ A}, R_G = 6.0\text{ }\Omega$ | | 9.4 | | ns |
| Rise Time | t_r | | | 4.0 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | 21 | | |
| Fall Time | t_f | | | 6.5 | | |

DRAIN-SOURCE DIODE CHARACTERISTICS

| | | | | | | | |
|-------------------------|----------|---|---------------------------|------|------|-----|----|
| Forward Diode Voltage | V_{SD} | $V_{GS} = 0\text{ V}, I_S = 2.0\text{ A}$ | $T_J = 25^\circ\text{C}$ | | 0.75 | 1.0 | V |
| | | | $T_J = 125^\circ\text{C}$ | | 0.59 | | |
| Reverse Recovery Time | t_{RR} | $V_{GS} = 0\text{ V}, dI_S/dt = 100\text{ A}/\mu\text{s}, I_S = 2.0\text{ A}$ | | 17.8 | | | ns |
| Charge Time | t_a | | | 8.3 | | | |
| Discharge Time | t_b | | | 9.5 | | | |
| Reverse Recovery Charge | Q_{RR} | | | 8.0 | | | nC |

PACKAGE PARASITIC VALUES

| | | | | | | |
|-------------------|-------|--------------------------|--|------|-----|----------|
| Source Inductance | L_S | $T_A = 25^\circ\text{C}$ | | 0.66 | | nH |
| Drain Inductance | L_D | | | 0.20 | | nH |
| Gate Inductance | L_G | | | 1.5 | | nH |
| Gate Resistance | R_G | | | 1.5 | 3.0 | Ω |

3. Pulse Test: pulse width = 300 μs , duty cycle $\leq 2\%$.

4. Switching characteristics are independent of operating junction temperatures.

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TYPICAL PERFORMANCE CURVES

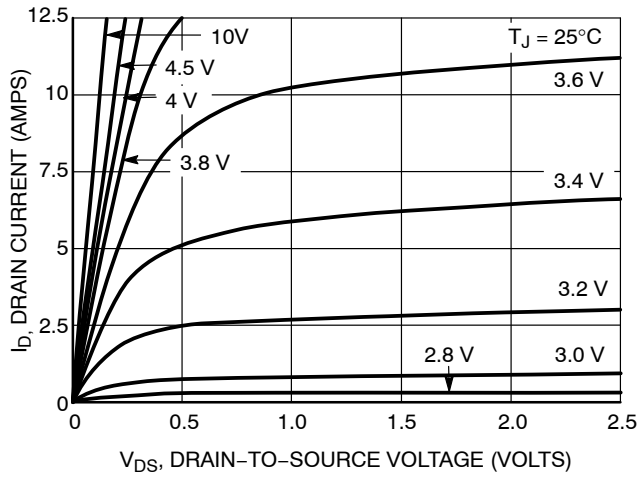


Figure 1. On-Region Characteristics

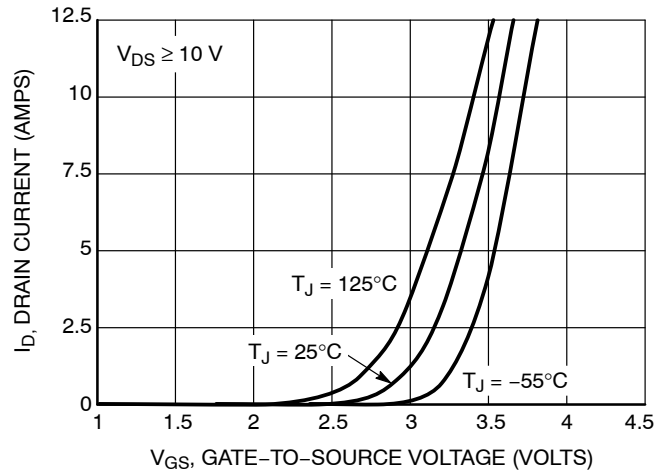


Figure 2. Transfer Characteristics

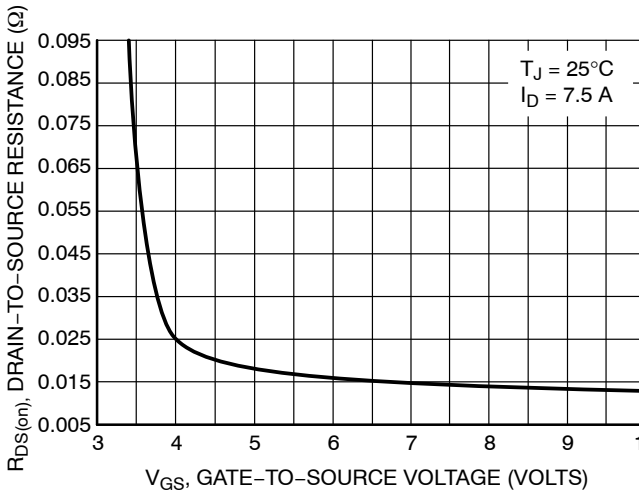


Figure 3. On-Resistance vs. Gate-to-Source Voltage

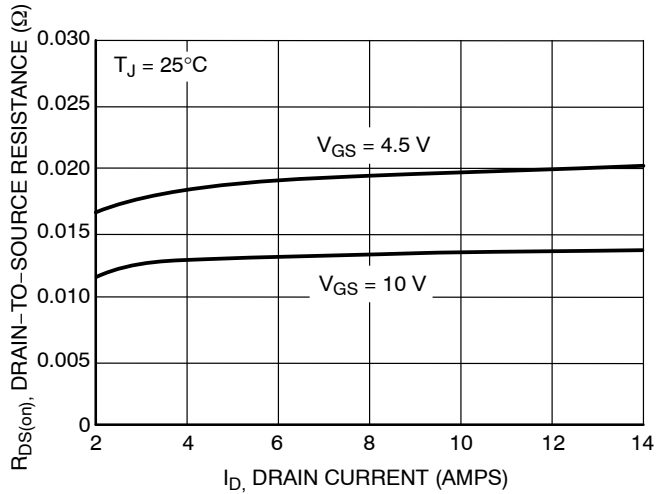


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

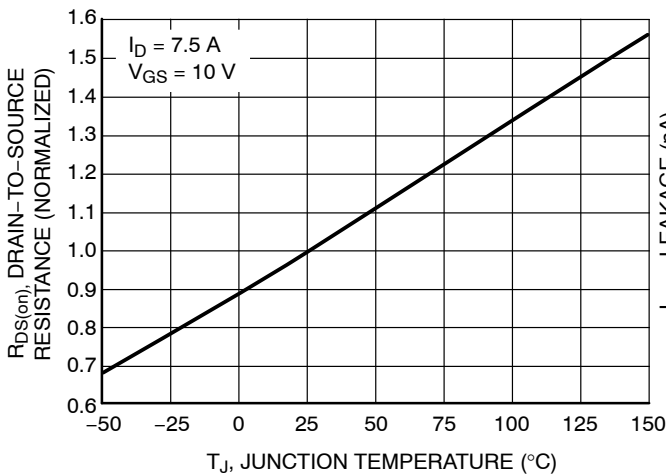


Figure 5. On-Resistance Variation with Temperature

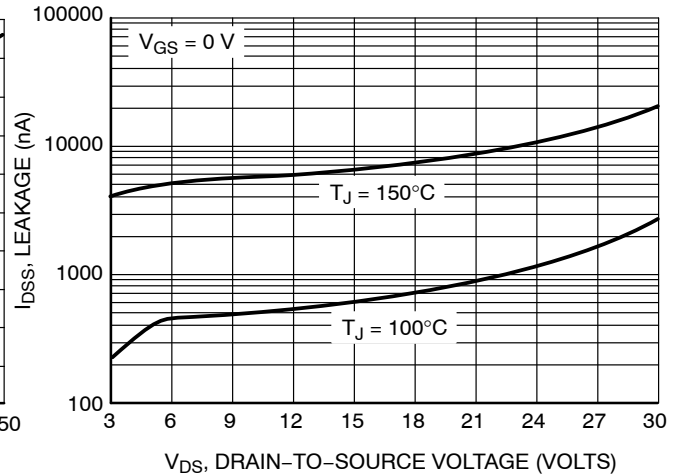


Figure 6. Drain-to-Source Leakage Current vs. Voltage

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TYPICAL PERFORMANCE CURVES

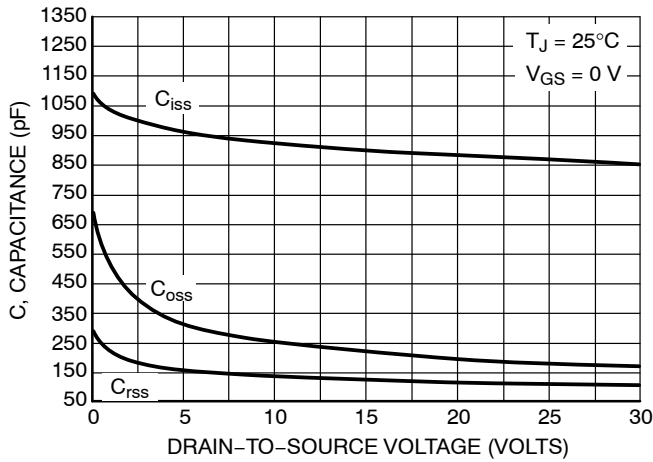


Figure 7. Capacitance Variation

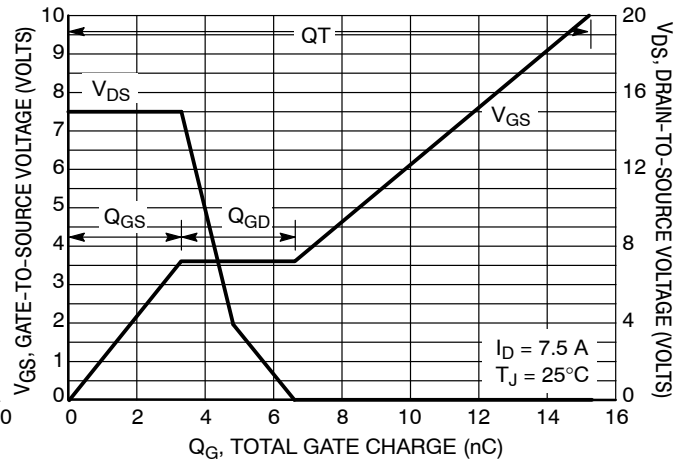


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

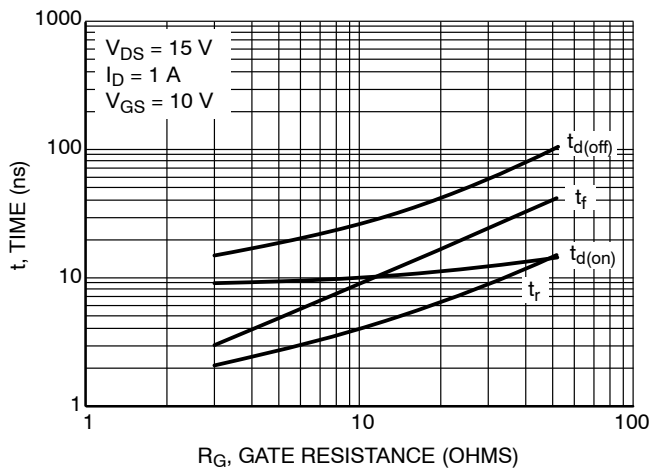


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

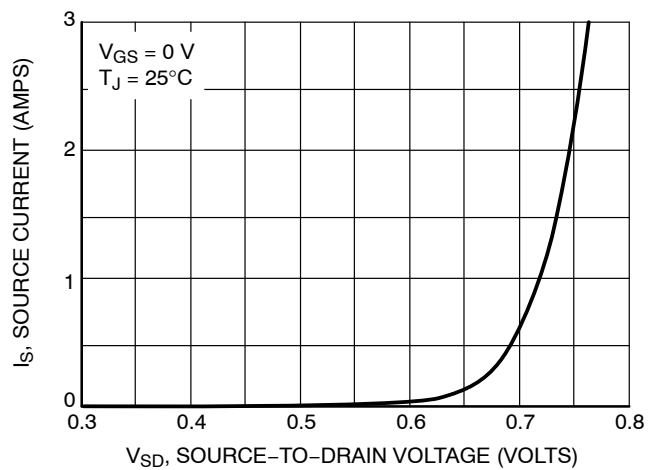


Figure 10. Diode Forward Voltage vs. Current

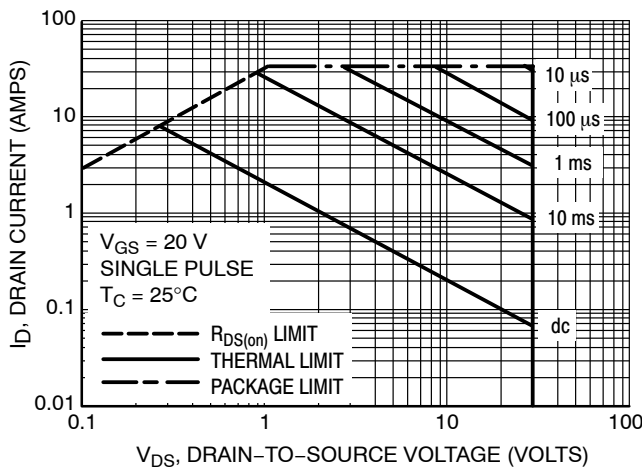


Figure 11. Maximum Rated Forward Biased Safe Operating Area

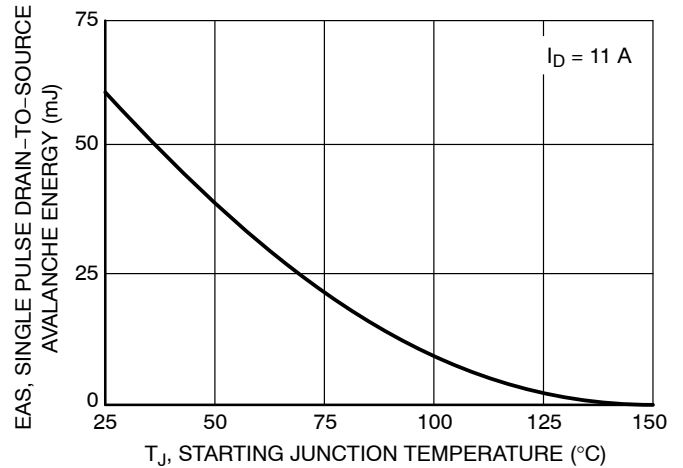


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

